

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 230257US0		SERIAL NO. 10/664,894	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Nathalie JAGER-LEZER			
				FILING DATE September 22, 2003		GROUP 1619	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA	2002/098217	07/25/2002	B. Piot, et al.			
	AB	2003/0031642	02/13/2003	N. Jager Lezer			
	AC	2004/0142831	07/22/2004	N. Jager Lezer			
	AD	2006/057085	03/16/2006	N. Jager Lezer			
	AE	3,802,841	04/09/1974	Jean-Baptiste Robin			
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	AG	6,491,931	12/10/2002	N. Collin			
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	EP 1 201 221	05/02/2002	EPO (Corresponds to US 2002/098217)			X
	AP	EP 1 053 742	11/22/2000	EPO (Corresponds to US 2006/057085) (English Abstract Provided)			X
	AQ	EP 1 208 836	05/29/2002	EPO	X		
	AR	EP 0 445 342	09/11/1991	EPO	X		
	AS	WO 00/72809	12/07/2000	WIPO	X		
	AT	JP H09-263 518	10/07/1997	Japan (English Abstract Provided)			X
	AU	JP 2002-154932	05/28/2002	Japan (English Abstract Provided)			X
	AV	JP 2001-48736	02/20/2001	Japan (English Abstract Provided)			X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	JP 2001-48750	02/20/2001	Japan (English Abstract Provided)		X	
	AP	JP 2002-145739	05/22/2002	Japan (Corresponds to US 2002/098217) (English Abstract Provided)		X	
	AQ	JP 2000-344627	12/12/2000	Japan (English Abstract Provided)		X	
	AR	JP 2002-173412	06/21/2002	Japan (Corresponds to US 6,503,521)		X	
	AS	JP 2004-155768	06/03/2004	Japan (w/English Translation)	X		
	AT						
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